

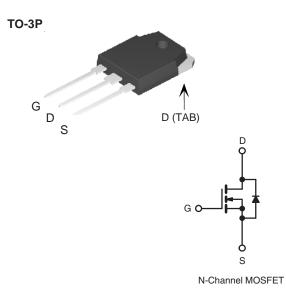
ROHS

COMPLIANT

## IRFPS38N60LPBF-VB Datasheet

## N-Channel 600V(D-S) Super Junction Power MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V) at T <sub>J</sub> max.	600					
R <sub>DS(on)</sub> at 25 °C (Ω)	$V_{GS} = 10 V$	0.06				
Q <sub>g</sub> max. (nC)	273					
Q <sub>gs</sub> (nC)	46					
Q <sub>gd</sub> (nC)	79					
Configuration	Single					



## FEATURES

- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (C<sub>iss</sub>)
- Reduced switching and conduction losses
- Ultra low gate charge (Q<sub>q</sub>)
- Avalanche energy rated (UIS)

#### **APPLICATIONS**

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Industrial
  - Welding
  - Induction heating
  - Motor drives
  - Battery chargers
  - Renewable energy
  - Solar (PV inverters)

<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_C = 25 \text{ °C}$ , unless otherwise noted)								
PARAMETER			SYMBOL	LIMIT	UNIT			
Drain-Source Voltage			V <sub>DS</sub>	600	v			
Gate-Source Voltage			V <sub>GS</sub>	± 30				
Continuous Drain Current (T <sub>J</sub> = 150 °C)	V <sub>GS</sub> at 10 V	$T_{C} = 25 \text{ °C}$ $T_{C} = 100 \text{ °C}$	I <sub>D</sub>	47				
				30	А			
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	142				
Linear Derating Factor				3.3	W/°C			
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	1410	mJ			
Maximum Power Dissipation			PD	415	W			
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C			
Drain-Source Voltage Slope	T <sub>J</sub> = 125 °C		-l\//-lt	37				
Reverse Diode dV/dt <sup>d</sup>			dV/dt	9	V/ns			
Soldering Recommendations (Peak Temperature) <sup>c</sup>	for 10 s			300	°C			

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature.

- b.  $V_{DD}$  = 50 V, starting T<sub>J</sub> = 25 °C, L = 28.2 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 10 A.
- c. 1.6 mm from case.
- d.  $I_{SD} \leq I_D, \, dI/dt$  = 100 A/µs, starting  $T_J$  = 25 °C.

## IRFPS38N60LPBF-VB



$\begin{array}{ c c c c c c } \hline PARAMETER & SYMBOL & TYP. & MAX. & UNIT \\ \hline Maximum Junction-to-Case (Drain) & R_{InJA} & - & 0.3 & & & & & & & & & & & & & & & & & & &$	THERMAL RESISTANCE RAT	INGS							
$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	PARAMETER	SYMBOL	TYP.	TYP. MAX.			UNIT		
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	Maximum Junction-to-Ambient	R <sub>thJA</sub>	- 40						
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	- 0.3				°C/W		
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$		•							
	<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C,	unless otherwi	se noted)						
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	PARAMETER	SYMBOL	TES	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Static	•	•				•		<b></b>
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> :	= 0 V, I <sub>D</sub> =	250 µA	600	-	-	V
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	$I_D = 1 \text{ mA}$	-	0.70	-	V/°C
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Source Threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> =	250 µA	2	-	4	V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Cata Cauraa Laakaga				-	-	± 100	nA	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gale-Source Leakage	IGSS			-	-	± 1	μA	
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	Zoro Cata Voltago Drain Current	I	V <sub>DS</sub> =	= 650 V, V <sub>C</sub>	<sub>as</sub> = 0 V	-	-	1	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Zero Gale Voltage Drain Gurrent	DSS	V <sub>DS</sub> = 520 \				-	25	μΑ
$ \begin{array}{ c c c c c c } \hline \textbf{Dynamic} & & & & & & & & & & & & & & & & & & &$	Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 V$		<sub>D</sub> = 24 A	-	0.06	-	Ω
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Forward Transconductance	9 <sub>fs</sub>	$V_{DS} = 30 \text{ V}, \text{ I}_{D} = 24 \text{ A}$		-	16.7	-	S	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Dynamic						•	•	
$ \begin{array}{ c c c c c c } \hline \text{Output Capacitance} & C_{oss} & V_{DS} = 100 \text{ V}, & - & 251 & - & - & 1 & - & - & - & 1 & - & - & $	Input Capacitance	C <sub>iss</sub>		$V_{CS} = 0 V_{c}$		-	5682	-	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Output Capacitance		$V_{DS} = 100 V,$		-	251	-	pF	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Reverse Transfer Capacitance	C <sub>rss</sub>			-	1	-		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $		C <sub>o(er)</sub>	$V_{\text{DS}}$ = 0 V to 520 V, $V_{\text{GS}}$ = 0 V		-	192	-		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $		C <sub>o(tr)</sub>			-	665	-		
$ \begin{split} \hline \begin{tabular}{ c c c c c c } \hline Gate-Drain Charge & Q_{gd} & & & & & & & & & & & & & & & & & & &$	Total Gate Charge	Qg				-	182	273	
$\begin{array}{c c c c c c c c c } \hline Turn-On Delay Time & t_{d(on)} & & & & & & & & & & & & & & & & & & &$	Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 \text{ V}$ $I_D = 24 \text{ A}, V_{DS} = 520 \text{ V}$		-	46	-	nC	
$\begin{array}{c c c c c c c c c } \hline Turn-On Delay Time & t_{d(on)} & & & & & & & & & & & & & & & & & & &$	Gate-Drain Charge	Q <sub>gd</sub>				-	79	-	1
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Turn-On Delay Time					-	47	94	
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Rise Time		V <sub>DD</sub> = 520 V, I <sub>D</sub> = 6 A,		-	87	131		
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Turn-Off Delay Time	t <sub>d(off)</sub>	V <sub>GS</sub> =			-	156	234	115
Drain-Source Body Diode CharacteristicsContinuous Source-Drain Diode CurrentIsMOSFET symbol showing the integral reverse $p - n$ junction diode-47APulsed Diode Forward CurrentIsMIsM $T_J = 25 ^{\circ}C$ , Is = 24 A, VGS = 0 V-0.91.2VDiode Forward VoltageVSD $T_J = 25 ^{\circ}C$ , Is = 24 A, VGS = 0 V-0.91.2VReverse Recovery Time $t_{rr}$ $T_J = 25 ^{\circ}C$ , Is = 24 A, dl/dt = 100 A/µs, VR = 25 V-1428µC	Fall Time	t <sub>f</sub>			-	103	206		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate Input Resistance	R <sub>g</sub>	f = 1 MHz, open drain			-	0.64	-	Ω
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Drain-Source Body Diode Characterist	ics							
Pulsed Diode Forward CurrentIsmIntegra reverse p - n junction diode139Diode Forward Voltage $V_{SD}$ $T_J = 25 \ ^{\circ}C$ , $I_S = 24 \ A$ , $V_{GS} = 0 \ V$ -0.91.2VReverse Recovery Time $t_{rr}$ $T_J = 25 \ ^{\circ}C$ , $I_F = I_S = 24 \ A$ , dl/dt = 100 A/µs, $V_R = 25 \ V$ -1428µC	Continuous Source-Drain Diode Current	I <sub>S</sub>	showing the integral reverse		-	-	47	A	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Pulsed Diode Forward Current	I <sub>SM</sub>			-	-	139		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Diode Forward Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 24 A, V <sub>GS</sub> = 0 V			-	0.9	1.2	V
Reverse Recovery Charge $Q_{rr}$ $T_J = 25 \ ^{\circ}C$ , $I_F = I_S = 24 \ A$ , $dl/dt = 100 \ A/\mu s$ , $V_R = 25 \ V$ -1428 $\mu C$			T <sub>J</sub> = 25 °C, I <sub>F</sub> = I <sub>S</sub> = 24 A,		-	753	1506	ns	
di/dt = 100 A/µs, v <sub>R</sub> = 25 v	Reverse Recovery Charge				-	14	28	μC	
					-	28	-		

#### Notes

a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .



## TYPCIAL CHARACTERISTICS (25 °C, unless otherwise noted)

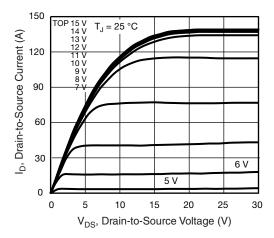


Fig. 1 - Typical Output Characteristics

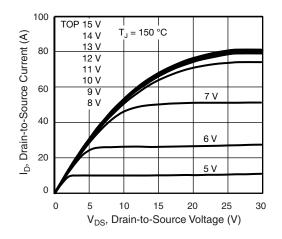


Fig. 2 - Typical Output Characteristics

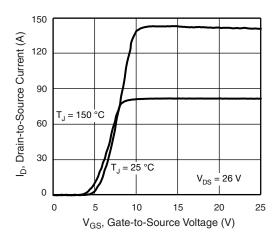


Fig. 3 - Typical Transfer Characteristics

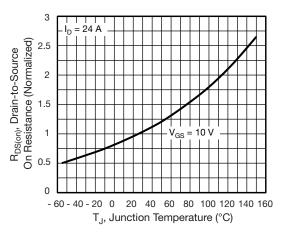


Fig. 4 - Normalized On-Resistance vs. Temperature

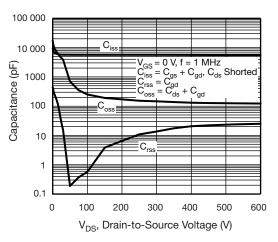


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

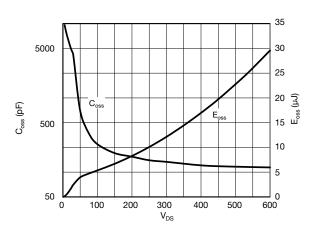


Fig. 6 - Coss and Eoss vs. VDS

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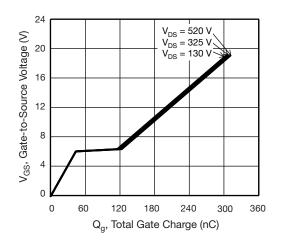


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

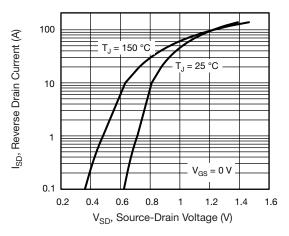


Fig. 8 - Typical Source-Drain Diode Forward Voltage

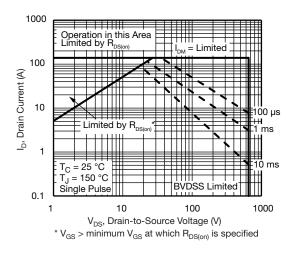


Fig. 9 - Maximum Safe Operating Area

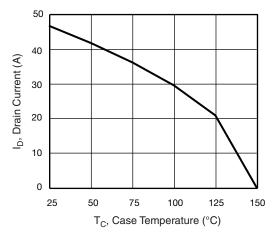


Fig. 10 - Maximum Drain Current vs. Case Temperature

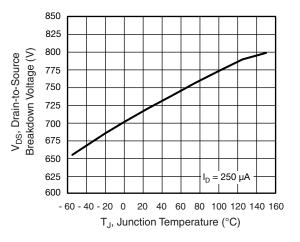
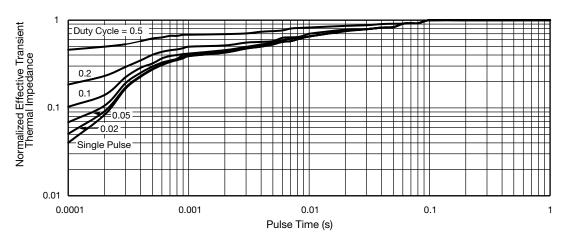


Fig. 11 - Temperature vs. Drain-to-Source Voltage

## IRFPS38N60LPBF-VB





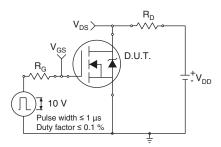


Fig. 13 - Switching Time Test Circuit

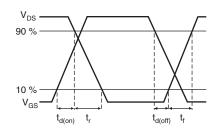


Fig. 14 - Switching Time Waveforms

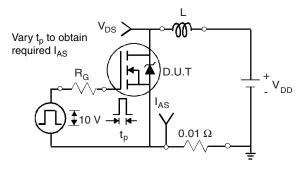


Fig. 15 - Unclamped Inductive Test Circuit

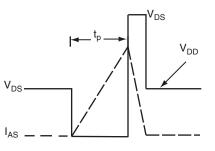


Fig. 16 - Unclamped Inductive Waveforms

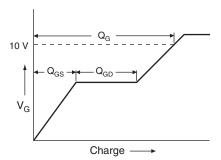


Fig. 17 - Basic Gate Charge Waveform

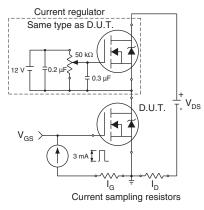


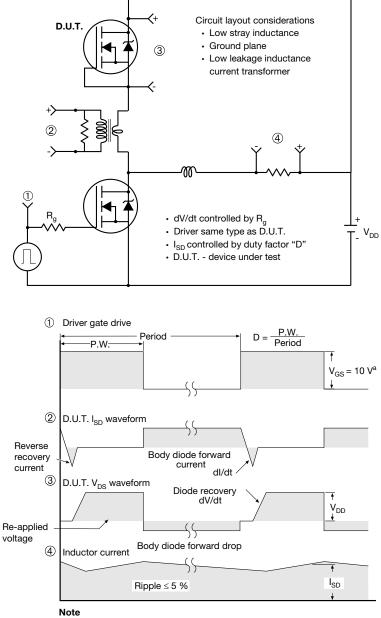
Fig. 18 - Gate Charge Test Circuit

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#### Peak Diode Recovery dV/dt Test Circuit



a.  $V_{GS} = 5$  V for logic level devices

Fig. 19 - For N-Channel



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